



09/413462

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PATENTS

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Eduard A. Cartier, et al.

Docket: 12906

Patent No.: 6,753,556

Dated: May 26, 2005

Issued: June 22, 2004

For: SILICATE GATE DIELECTRIC

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Certificate  
JUN 06 2005  
of Correction

REQUEST FOR CERTIFICATE OF CORRECTION

Sir:

It appears that errors have been introduced in the course of printing the Patent issued in the above application, and it is respectfully requested that the Commissioner issue a Certificate of Correction in the following respects:

Title Page  
(57)

References Cited  
U.S. PATENT DOCUMENT are missing

5,190,888 \* 3/2/93 Schwalke et al.....  
5,258,640 \* 11/2/93 Hsich et al.....  
5,541,131 \* 7/30/96 Yoo et al.....  
5,554,560 \* 9/10/96 Hsue et al.....  
5,672,898 \* 9/30/97 Keller et al.....  
5,852,318 \* 12/22/98 Chikamatsu et al.....  
5,876,788 \* 3/2/99 Bronner et al.....

**OTHER PUBLICATIONS  
(ARE MISSING)**

**Hubbard, et al., "Thermodynamic Stability of Binary Oxides in Contact With Silicon," J. Mater. Res., Vol. 81 No. 11, pp. 2757-2776 (1996)**

**McKee, et al., "Crystalline Oxides on Silicon: The First Five Monolayers," Physical Review Letters, Vol. 81, No. 14, pp. 3014-3017 (1998)**

**Respectfully submitted,**

A handwritten signature in black ink, appearing to read 'LSZ', followed by a long horizontal line extending to the right.

**Leslie S. Szivos  
Reg. No. 39,394**

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# UNITED STATES PATENT AND TRADEMARK OFFICE CERTIFICATE OF CORRECTION

PATENT NO : 6,753,556 B2  
APPLICATION NO : 09/413,462  
ISSUE DATE : June 22, 2004  
INVENTOR(S) : Eduard A. Cartier, et al.

It is certified that an error appears or errors appear in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

(58) Title Page  
References Cited  
U.S. PATENT DOCUMENT are missing

5,190,888 \* 3/2/93 Schwalke et al.....  
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